# MOSFET – Single, P-Channel, Small Signal, XLLGA3, 0.62 x 0.62 x 0.4 mm -30 V, -130 mA

#### **Features**

- Single P-Channel MOSFET
- Ultra Small and Thin Package (0.62 x 0.62 x 0.4 mm)
- Low R<sub>DS(on)</sub> Solution in 0.62 x 0.62 mm Package
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- Small Signal Load Switch
- Analog Switch
- High Speed Interfacing
- Optimized for Power Management in Ultra Portable Products

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter		Symbol	Value	Units	
Drain-to-Source Voltage		$V_{DSS}$	-30	V	
Gate-to-Source Vol	Gate-to-Source Voltage		V <sub>GS</sub>	±20	V
Continuous Drain			I <sub>D</sub>	-137	mA
Current (Note 1)	State	T <sub>A</sub> = 85°C		-99	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-148	
Power Dissipa- tion (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	121	mW
	t ≤ 5 s	T <sub>A</sub> = 25°C		140	
Pulsed Drain Current $t_p = 10 \mu s$		I <sub>DM</sub>	-550	mA	
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C	
Source Current (Body Diode)		Is	-137	mA	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	1035	°C/W
Junction-to-Ambient – t ≤ 5 s (Note 1)	$R_{\theta JA}$	895	

- Surface Mounted on FR4 Board using the minimum recommended pad size, (or 2 mm<sup>2</sup>), 1 oz Cu.
- 2. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.



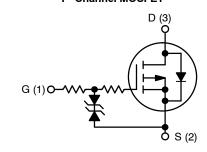
#### ON Semiconductor®

#### www.onsemi.com

#### **MOSFET**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
20.14	4.0 Ω @ –10 V	100 1
-30 V	7.0 Ω @ -4.5 V	–130 mA

#### P-Channel MOSFET



#### MARKING DIAGRAM



#### XLLGA3 CASE 713AA



J = Specific Device CodeM = Date Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTNS41006PZTCG	XLLGA3 (Pb-Free)	8000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS		•		•	-		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I	D = -250 μA	-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = -250 \mu A$ , ref to 25°C			32		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = -24 \text{ V}$	T <sub>J</sub> = 25°C			-1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, \	/ <sub>GS</sub> = ±12 V			±2.0	μΑ
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$	I <sub>D</sub> = -250 μA	-1.0		-3.0	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = −10 V,	$I_D = -100 \text{ mA}$		2.1	4.0	Ω
		V <sub>GS</sub> = -4.5 V	⁄, I <sub>D</sub> = −50 mA		3.3	7.0	
Forward Transconductance	9FS	$V_{DS} = -5 V$ ,	I <sub>D</sub> = -50 mA		0.14		S
Source-Drain Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	I <sub>S</sub> = -50 mA		-0.8	-1.0	V
CHARGES & CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				9.1		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, } f = 10 \text{ kHz,}$ $V_{DS} = -15 \text{ V}$			3.2		
Reverse Transfer Capacitance	C <sub>RSS</sub>				1.9		
Total Gate Charge	$Q_{G(TOT)}$	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -1	V <sub>DS</sub> = -15 V, 00 mA		1.4		nC
Total Gate Charge	Q <sub>G(TOT)</sub>				0.7		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$ $I_{D} = -100 \text{ mA}$			0.3		
Gate-to-Source Charge	Q <sub>GS</sub>				0.4		
Gate-to-Drain Charge	$Q_{GD}$				0.1		
SWITCHING CHARACTERISTICS, VG	S = -10 V (Note 3)	1					
Turn-On Delay Time	t <sub>d(ON)</sub>				22.5		ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = -10 V, $V_{DD}$ = -15 V, $I_{D}$ = -100 mA, $R_{G}$ = 2 $\Omega$			33.1		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				178.9		
Fall Time	t <sub>f</sub>				101.3		
SWITCHING CHARACTERISTICS, VG	S = -4.5 V (Note 3	·)					
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -15 \text{ V},$ $I_{D} = -100 \text{ mA}, R_{G} = 2 \Omega$			58.7		ns
Rise Time	t <sub>r</sub>				137.3		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				78.6		
Fall Time	t <sub>f</sub>				99.7		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

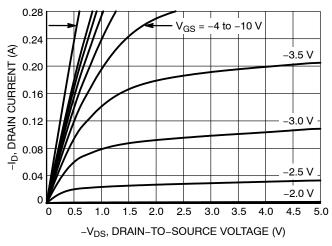


Figure 1. On-Region Characteristics

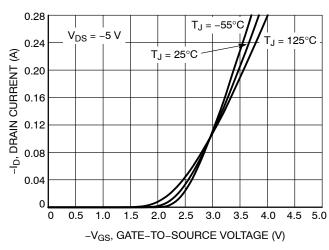


Figure 2. Transfer Characteristics

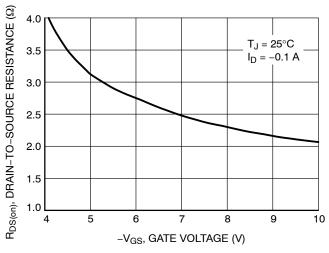


Figure 3. On-Resistance vs. Gate-to-Source Voltage

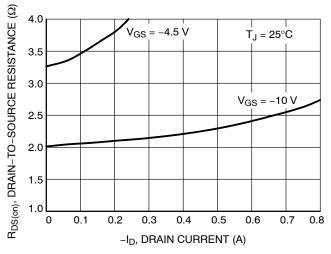


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

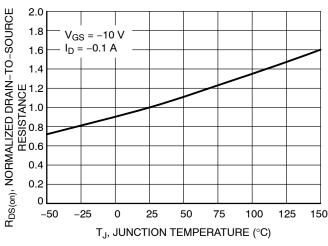


Figure 5. On–Resistance Variation with Temperature

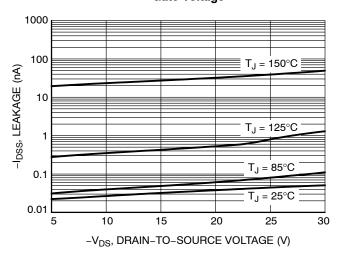


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

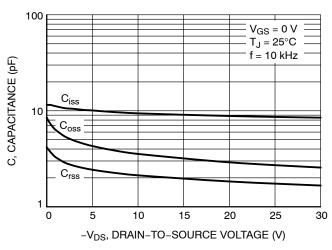


Figure 7. Capacitance Variation

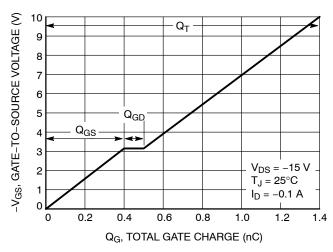


Figure 8. Gate-to-Source vs. Total Charge

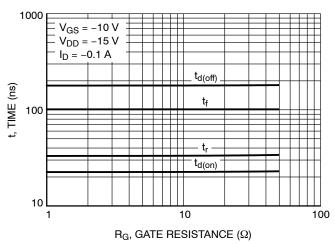


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

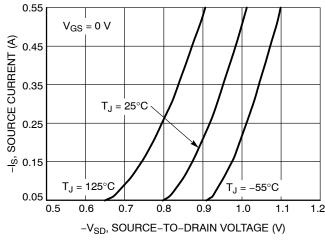


Figure 10. Diode Forward Voltage vs. Current

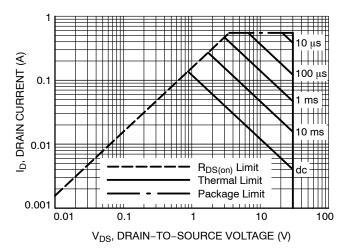


Figure 11. Maximum Rated Forward Biased Safe Operating Area

### **TYPICAL CHARACTERISTICS**

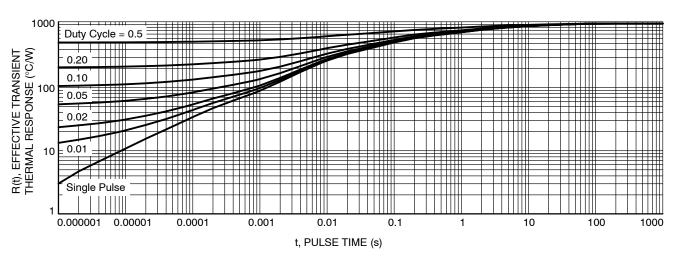
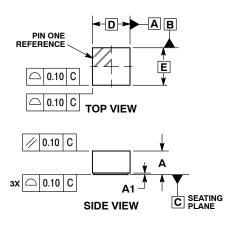
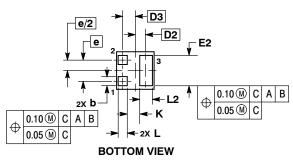


Figure 12. FET Thermal Response

#### PACKAGE DIMENSIONS

#### XLLGA3, 0.62x0.62, 0.35P CASE 713AA ISSUE B



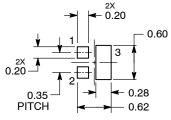


#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS

	MILLIMETERS		
DIM	MIN	MAX	
Α	0.340	0.440	
A1	0.000	0.030	
b	0.100	0.200	
D	0.620 BSC		
D2	0.175 BSC		
D3	0.205 BSC		
Е	0.620 BSC		
E2	0.400	0.600	
е	0.350 BSC		
K	0.200 REF		
L	0.090	0.210	
L2	0.110	0.310	

## MINIMUM RECOMMENDED SOLDER FOOTPRINT\*



DIMENSIONS: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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